

T-4-85

OPTOCOUPLER

Opto-isolator comprising an infrared emitting GaAs diode and a silicon npn Darlington phototransistor with accessible base. Plastic 6-lead dual-in line (DIL) envelope.

Features

- Very high output/input DC current transfer ratio
- High isolation voltage of 3.12 kV RMS and 4.4 kV DC
- Working voltage 2.5 kV DC

A VDE and UL version is available; see CNX48U.

QUICK REFERENCE DATA

Diode

Continuous reverse voltage	V_R	max.	5 V
DC forward current	I_F	max.	100 mA
(peak value); $t_p = 10 \mu s$; $\delta = 0.01$	I_{FRM}	max.	3 A
Total power dissipation up to $T_{amb} = 25^\circ C$	P_{tot}	max.	200 mW

Transistor

Collector-emitter voltage (open base)	V_{CEO}	max.	30 V
Total power dissipation up to $T_{amb} = 25^\circ C$	P_{tot}	max.	200 mW

Optocoupler

Output/input DC current transfer ratio (CTR) $I_F = 1 \text{ mA}$; $V_{CE} = 1 \text{ V}$; ($I_B = 0$)	I_C/I_F	min.	5
Collector-cut-off current (dark) $V_{CC} = 10 \text{ V}$; working voltage = 2.5 kV DC diode: $I_F = 0$ (see also Fig. 2)	I_{CEW}	max.	1 μA
Isolation voltage DC	V_{IORM}	min.	4.4 kV
AC (RMS value)			3.12 kV

MECHANICAL DATA

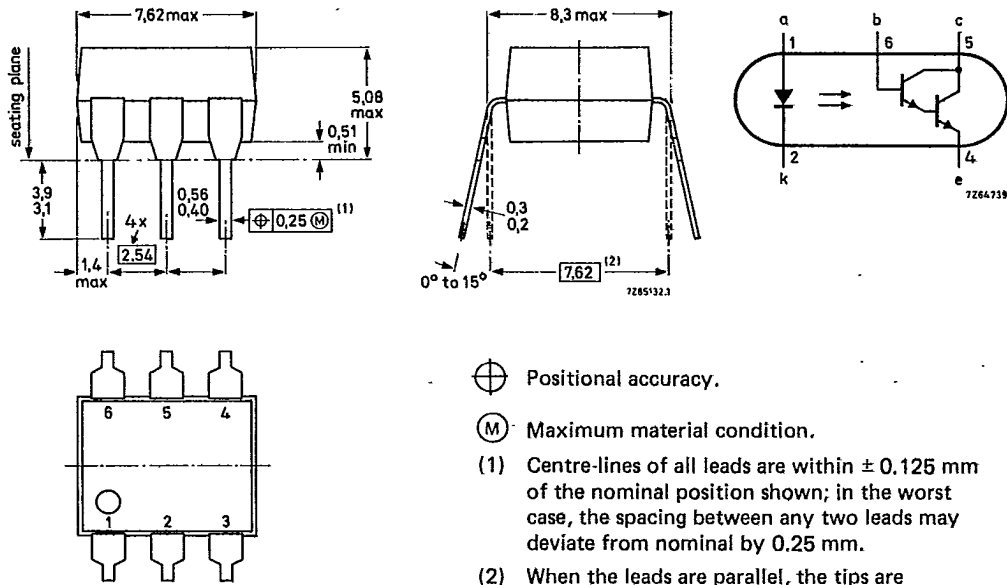
SOT90B (see Fig. 1).

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MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT90B.



⊕ Positional accuracy.

Ⓜ Maximum material condition.

- (1) Centre-lines of all leads are within ± 0.125 mm of the nominal position shown; in the worst case, the spacing between any two leads may deviate from nominal by 0.25 mm.
- (2) When the leads are parallel, the tips are in position for automatic insertion.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Diode

Continuous reverse voltage	V_R	max.	5 V
DC forward current (peak value); $t_p = 10 \mu s$; $\delta = 0.01$	I_F	max.	100 mA
	I_{FRM}	max.	3 A
Total power dissipation up to $T_{amb} = 25^\circ C$	P_{tot}	max.	200 mW
Junction temperature	T_j	max.	125 $^\circ C$

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Transistor

Collector-emitter breakdown voltage $I_C = 1 \text{ mA}$	$V_{(BR)CEO}$	min.	30 V
Collector-base breakdown voltage $I_C = 0.1 \text{ mA}$	$V_{(BR)CBO}$	min.	30 V
Emitter-collector breakdown voltage $I_E = 0.1 \text{ mA}$	$V_{(BR)ECO}$	min.	6 V
DC collector current	I_C	max.	100 mA
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$	P_{tot}	max.	200 mW
Junction temperature	T_j	max.	125 $^\circ\text{C}$

Optocoupler

Storage temperature range	T_{stg}		-55 to + 150 $^\circ\text{C}$
Operating ambient temperature range	T_{amb}		-40 to + 100 $^\circ\text{C}$
Lead soldering temperature up to the seating plane; $t_{sld} < 10 \text{ s}$	T_{sld}	max.	260 $^\circ\text{C}$

THERMAL RESISTANCE

From junction to ambient in free air diode and transistor	$R_{th \text{ j-a}}$	=	500 K/W
From junction to ambient, device mounted on a printed-circuit board diode and transistor	$R_{th \text{ j-a}}$	=	400 K/W

ISOLATION RELATED VALUES

External air gap (clearance) input terminals to output terminals	$L(I01)$	min.	7.2 mm
External tracking path (creepage distance) input terminals to output terminals	$L(I02)$	min.	7.0 mm
Tracking resistance (KB value)			KB-100/A
Internal plastic gap (clearance) isolation thickness between emitter and receiver		min.	1 mm

CHARACTERISTICS

$T_j = 25 \text{ }^\circ\text{C}$ unless otherwise specified

Diode

Forward voltage $I_F = 10 \text{ mA}$	V_F	typ. max.	1.15 V 1.3 V
Reverse current $V_R = 5 \text{ V}$	I_R	max.	10 μA

Transistor ($I_F = 0$)

Collector cut-off current (dark) $V_{CE} = 10\text{ V}$	I_{CEO}	typ.	20 nA
		max.	100 nA
$V_{CB} = 10\text{ V}$	I_{CEO}	max.	20 nA
Collector-emitter breakdown voltage at $I_C = 1\text{ mA}$	$V_{(BR)CEO}$	min.	30 V
Collector-base breakdown voltage at $I_C = 0.1\text{ mA}$	$V_{(BR)CBO}$	min.	30 V
Emitter-base breakdown voltage at $I_E = 0.1\text{ mA}$	$V_{(BR)ECO}$	min.	6 V

Optocoupler ($I_B = 0$) (note 1)

Output/input DC current transfer ratio (CTR)

$I_F = 0.5\text{ mA}; V_{CE} = 1\text{ V}$	I_C/I_F	min.	3.5
$I_F = 1.0\text{ mA}; V_{CE} = 1\text{ V}$	I_C/I_F	min.	5
$I_F = 10\text{ mA}; V_{CE} = 1\text{ V}$	I_C/I_F	min.	6

Collector cut-off current (dark); see Fig. 2 (note 2)

$V_{CC} = 10\text{ V};$ working voltage = 2.5 kV DC	I_{CEW}	max.	1 μA
$V_{CC} = 10\text{ V};$ working voltage = 2.5 kV DC; $T_j = 70\text{ }^\circ\text{C}$	I_{CEW}	max.	1000 μA

Collector-emitter saturation voltage

$I_F = 5\text{ mA}; I_C = 10\text{ mA}$	V_{CEsat}	max.	1 V
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Isolation voltage (note 3)

$t = 1\text{ min}$			
DC			
AC (RMS value)	V_{IORM}	min.	4.4 kV 3.12 kV

Collector capacitance at $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10\text{ V}$	$C_{b'c}$	typ.	4.5 pF
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Capacitance between input and output

$I_F = 0; V = 0; f = 1\text{ MHz}$	C_{io}	typ.	0.6 pF
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Insulation resistance between input and output

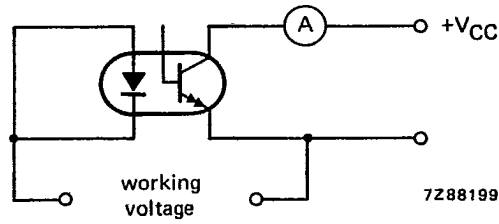
$\pm V_{IO} = 1\text{ kV}$	R_{IO}	min.	10 $\text{G}\Omega$
		typ.	1 $\text{T}\Omega$

Switching times (see Figs 3 and 4)

$I_{Fon} = 10\text{ mA}; V_{CC} = 5\text{ V}; R_E = 100\ \Omega; R_{BE} = 1\text{ M}\Omega$	t_{on}	typ.	5 μs
	t_{off}	typ.	30 μs
$I_{Fon} = 1\text{ mA}; V_{CC} = 5\text{ V}; R_E = 1\text{ k}\Omega; R_{BE} = 10\text{ M}\Omega$	t_{on}	typ.	50 μs
	t_{off}	typ.	250 μs

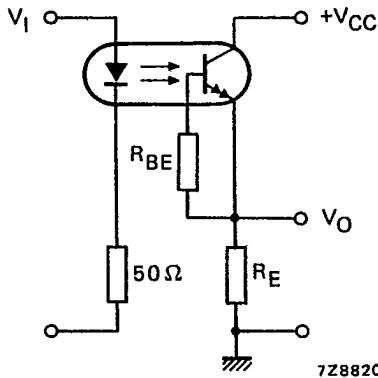
Notes

1. Where the phototransistor receives light from the diode the O (for open base) has been omitted from the symbols.
2. As quality assurance (on a sample basis), these parameters are covered by a 1000 h reliability test.
3. Every single product is tested by applying an isolation test voltage of 3750 V AC (RMS) for 2 seconds between the shorted input (diode) leads and the shorted output (phototransistor) leads.



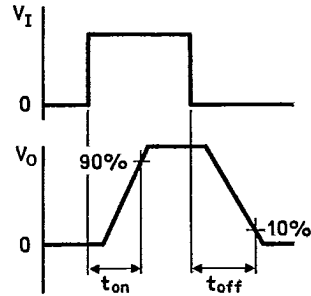
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Fig. 2.



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Fig. 3 Switching circuit.



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Fig. 4 Waveforms.

CNX48

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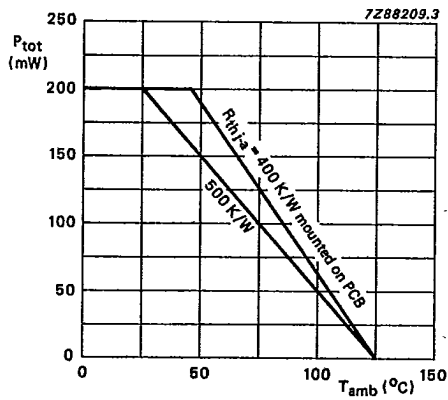


Fig. 5 Power derating curve for diode and transistor as a function of temperature.

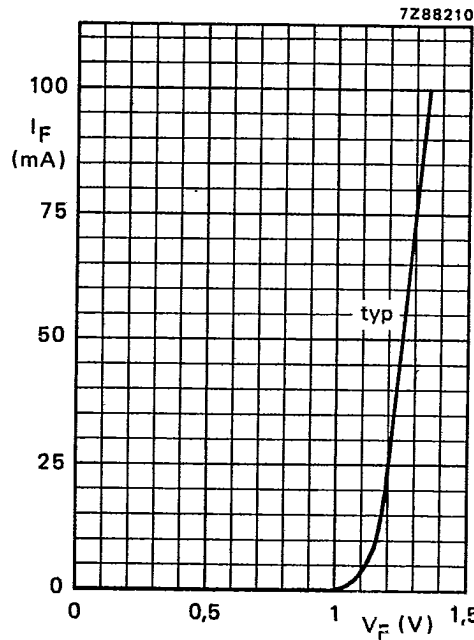


Fig. 6 $T_{amb} = 25\text{ }^\circ\text{C}$.

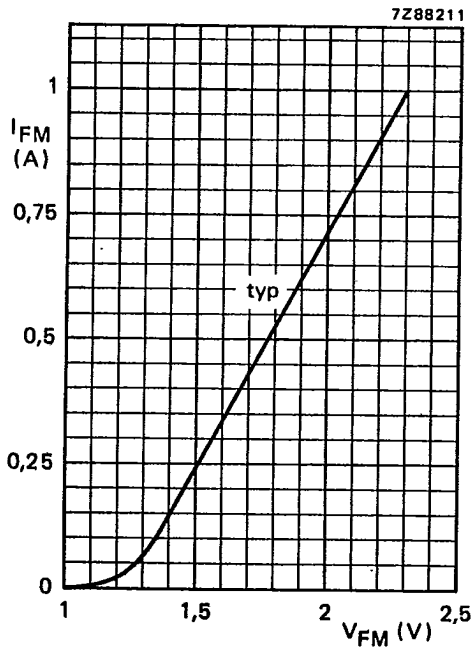


Fig. 7 $T_{amb} = 25\text{ }^\circ\text{C}$; $t_p = 10\text{ }\mu\text{s}$; $\delta = 0.01$.

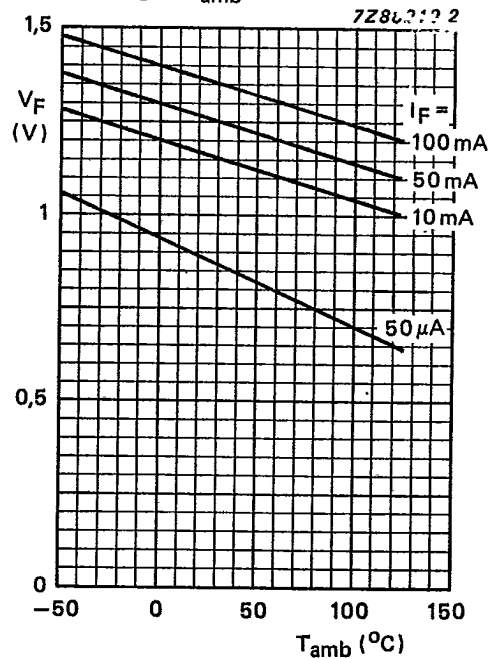


Fig. 8 Typical values.

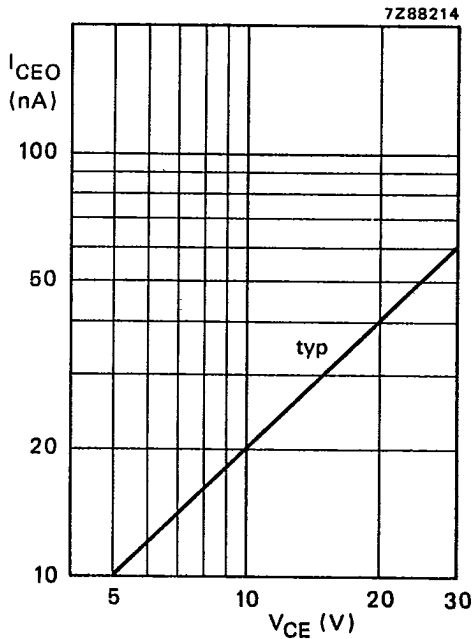


Fig. 9 $I_F = 0$; $T_j = 25^\circ\text{C}$.

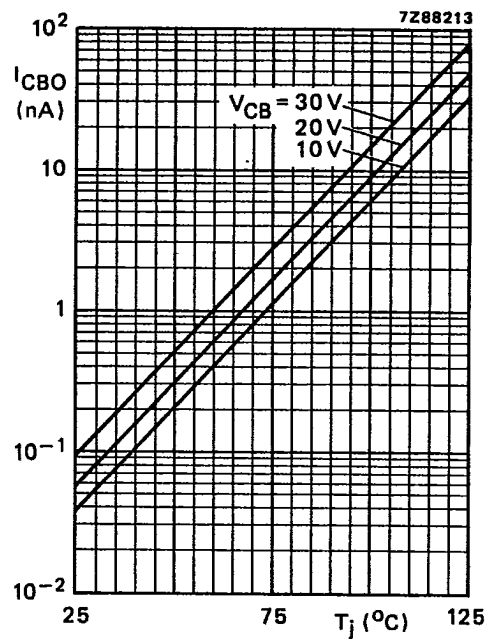


Fig. 10 Typical values.

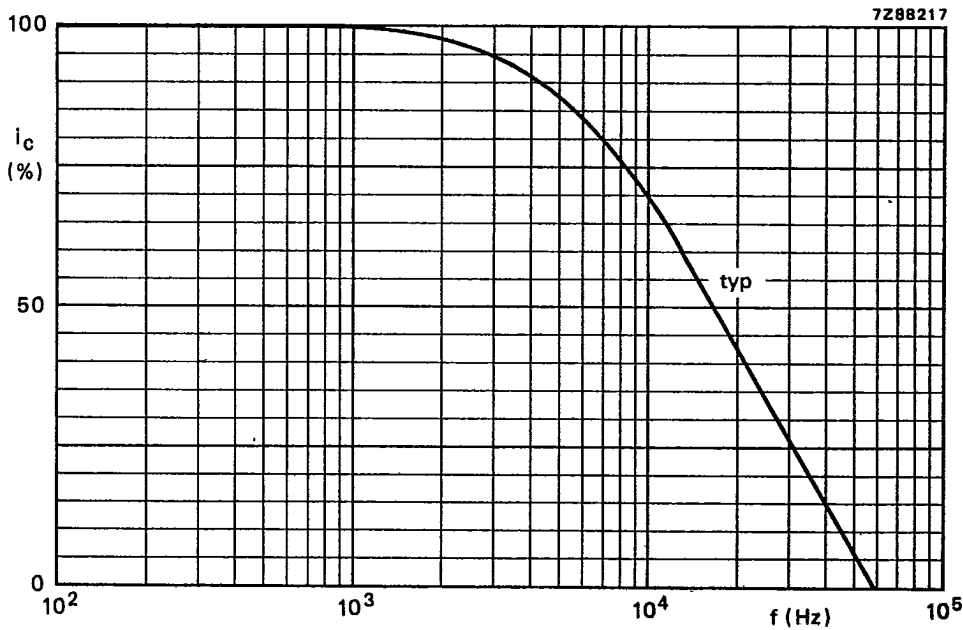


Fig. 11 $I_C = 10\text{ mA}$; $V_{CC} = 5\text{ V}$; $R_E = 100\ \Omega$; $R_{BE} = 1\text{ M}\Omega$; see also Fig. 4.

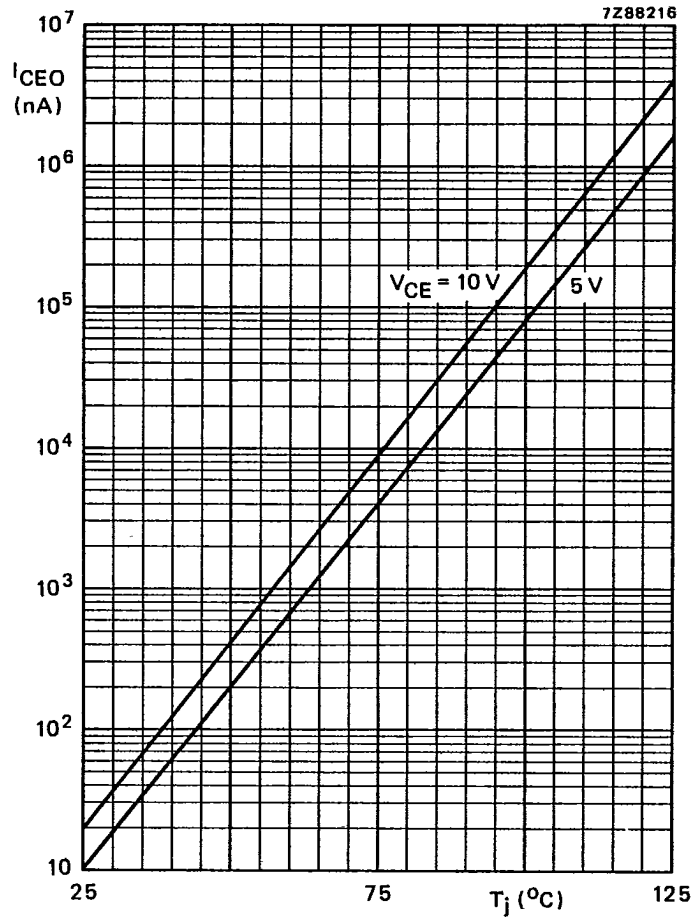


Fig. 12 $I_F = 0$; typical values.

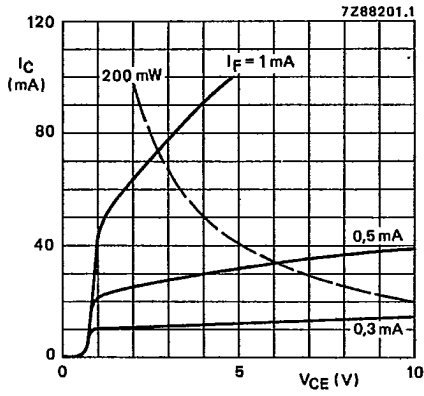


Fig. 13 Typical values; $T_{amb} = 25$ °C.

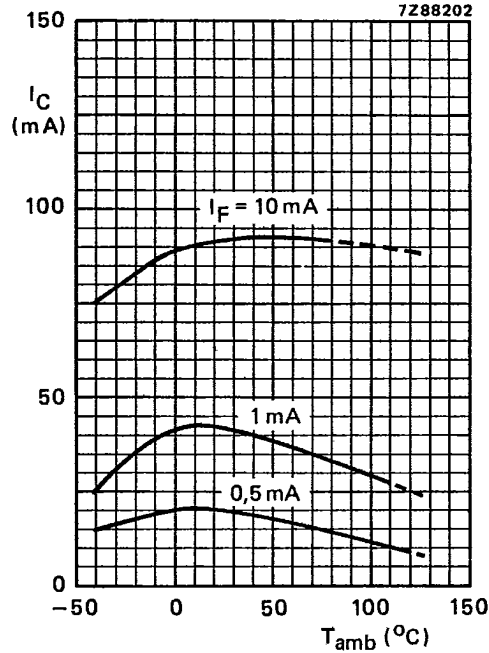


Fig. 14 Typical values; $I_B = 0$; $V_{CE} = 1$ V.

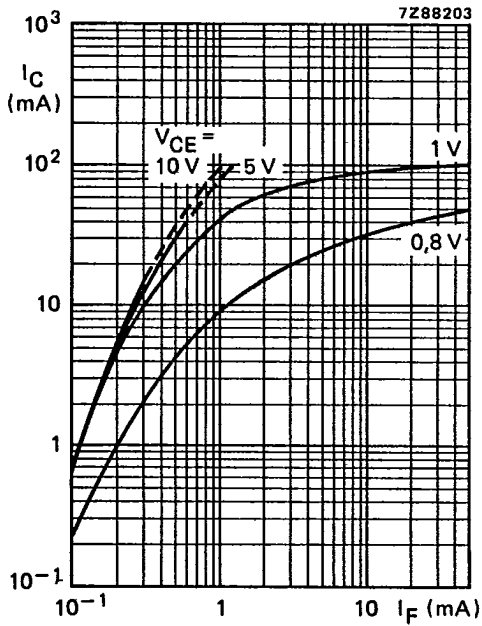


Fig. 15 Typical values; $I_B = 0$; $T_{amb} = 25$ °C.

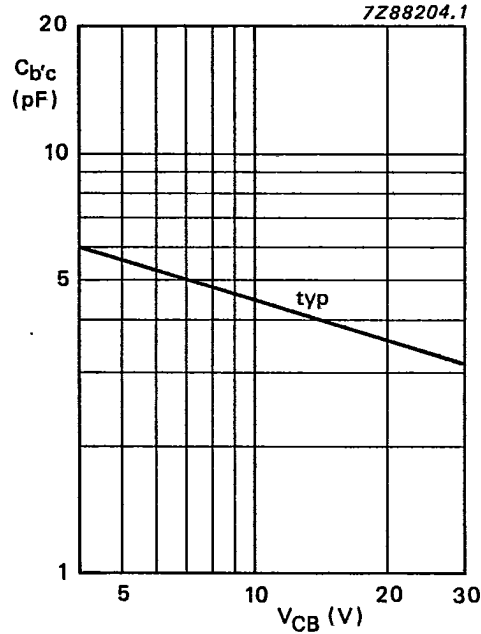


Fig. 16 $I_E = I_e = 0$; $f = 1$ MHz; $T_{amb} = 25$ °C.

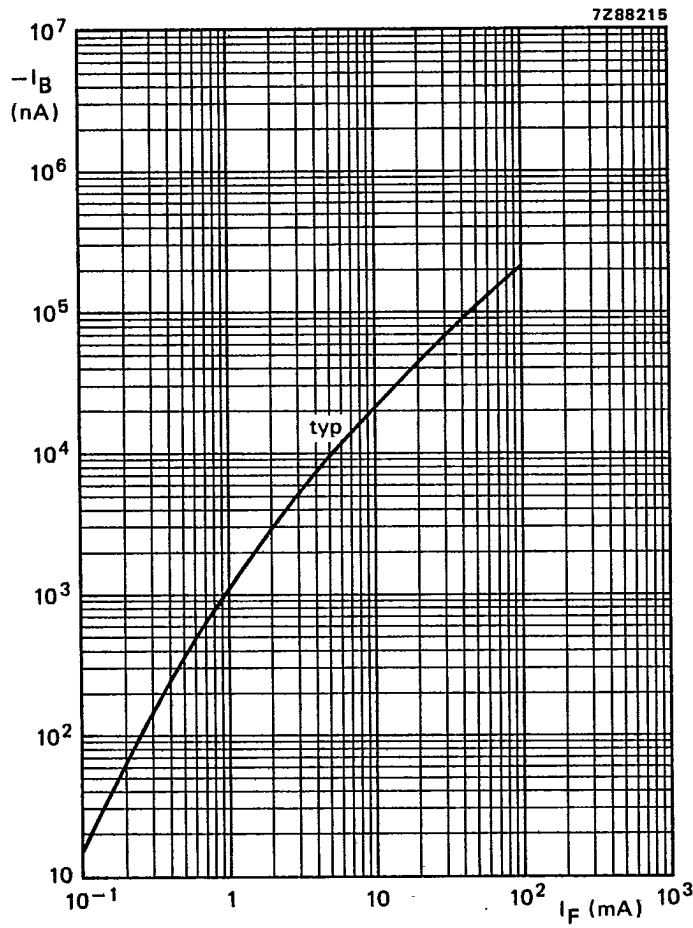


Fig. 17 $I_E = 0$; $V_{CB} = 5$ V; $T_{amb} = 25$ °C.

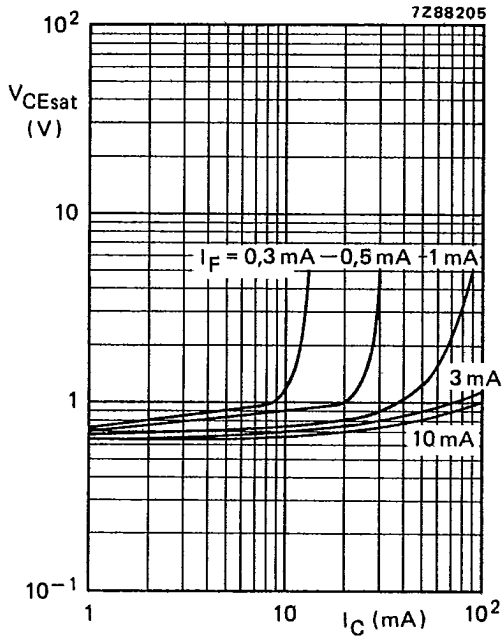


Fig. 18 Typical values; $I_B = 0$; $T_{amb} = 25^\circ\text{C}$.

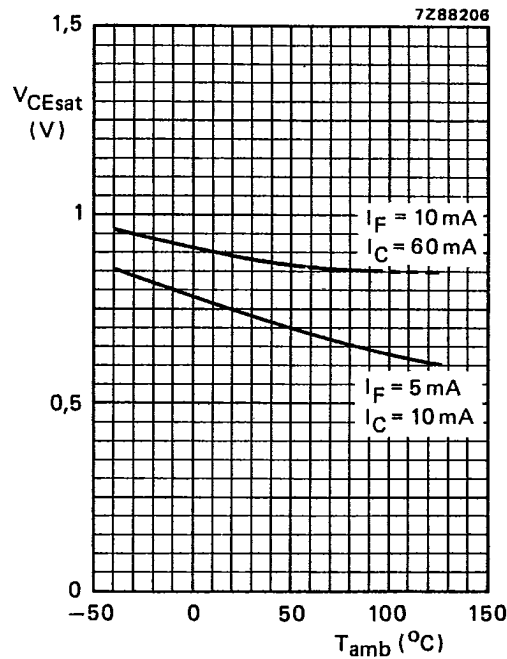


Fig. 19 Typical values; $I_B = 0$.

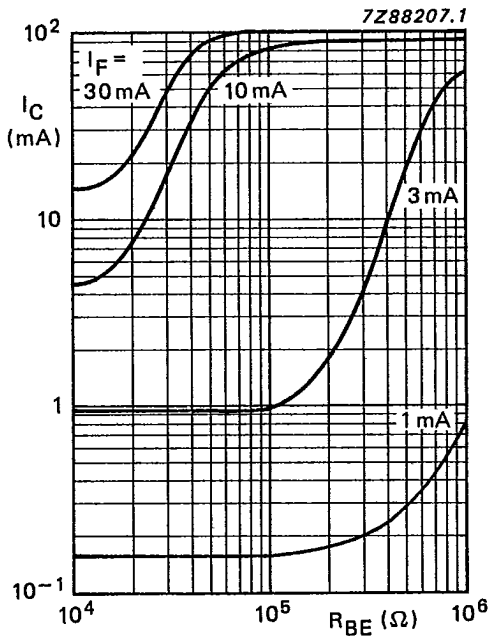


Fig. 20 Typ. values; $V_{CE} = 1 \text{ V}$; $T_{amb} = 25^\circ\text{C}$.

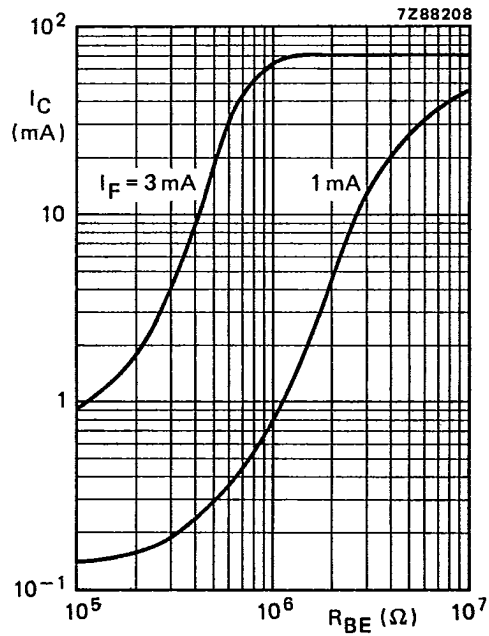


Fig. 21 Typ. values; $V_{CE} = 1 \text{ V}$; $T_{amb} = 25^\circ\text{C}$.